

## Schottky Barrier Chips for Hybrid Integrated Circuits

### Technical Data

HSMS-0005/06 HSMS-8002/12

#### **Features**

- Thermocompression/ Thermosonically Bondable
- Gold Metallization
- Silicon Nitride Passivation
- Uniform Electrical Characteristics
- Batch Matched Versions Available
- Planar Construction
- Available in Many Electrical Selections
- Ideal for Hybrid Integrated Circuits

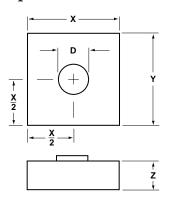
### **Description/Applications**

These Schottky chips are designed for hybrid applications at DC through K-band frequencies. The passivated planar construction of these Schottky chips provides a wide temperature range capability combined with broad bandwidth performance.

A variety of chips are provided which are optimized for various analog and digital applications. Typical applications of Schottky chips are mixing, detecting, switching, gating, sampling, and wave shaping.

This series of Schottky diode chips are specifically designed for analog and digital hybrid applications requiring thermosonic or thermocompression bonding techniques. The large bonding pad allows easy bonding. The top metallization is a layer of gold deposited on adhesive metal layers for a tarnish-free surface that allows either thermosonic or thermocompression bonding techniques. The bottom metallization is also gold, suitable for epoxy or eutectic die attach methods.

### **Chip Dimensions**



DIMENSIONS	PART NO. HSMS-			
	-0006/-8002	-0005		
	75	55		
D	(3)	(2)		
	250	250		
Х	(10)	(10)		
	275	250		
Y	(11)	(10)		
	150	150		
Z	(8)	(6)		
Top Contact	Anode	Cathode		

#### NOTES:

- 1. Dimensions in mlcrons (1/1000 inch).
- 2. Dimension tolerance is  $\pm 30 \mu$ .
- All contact metallization is gold.

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### Absolute Maximum Ratings, $T_A = 25^{\circ}C$

Symbol	Parameter	Units	HSMS-8002	HSMS-0005
P <sub>T</sub>	Total device dissipation, measured in an infinite heatsink. Derate linearly to zero at maximum rated temperature		75	75
$P_{IV}$	Peak Inverse Voltage	V	4.0	2.0
TJ	Junction Temperature (maximum)	°C	150	200
$T_{STG}$	Storage Temp. Range	°C	-65 to 150	-65 to 200
T <sub>OP</sub>	Operating Temperature	°C	-65 to 150	-65 to 200

Note: Operation in excess of any one of these conditions may result in permanent damage to the device.

### DC Electrical Specifications at $T_A = 25$ °C

### Schottky Barrier Chips for Microwave and RF Mixers

Part Number HSMS-	Batch Matched <sup>[1]</sup> HSMS-	Nearest Equivalent Packaged Part: HSMS-	Minimum Breakdown Voltage V <sub>BR</sub> (V)	$\begin{array}{c} \text{Maximum} \\ \text{Forward} \\ \text{Voltage} \\ \text{V}_{\text{F}} \ (\text{mV}) \end{array}$	Maximum Forward Voltage V <sub>F</sub> (mV)	$\begin{array}{c} \text{Maximum} \\ \text{Capacitance} \\ \text{C}_{\text{T}} \text{ (pF)} \end{array}$	$\begin{array}{c} \textbf{Maximum} \\ \textbf{Dynamic} \\ \textbf{Resistance} \\ \textbf{R}_{\textbf{D}} \ (\Omega)^{[2]} \end{array}$
8002	8012	8101	4	250	350	0.16	14
Test Conditions	$\Delta V_F = 15 \text{mV}$ $I_F = 1 \text{mA}$		$I_R = 10 \mu\text{A}$	$I_{\mathrm{F}} =$	1 mA	$V_{R} = 0 V$ $f = 1.0 MHz$	$I_F = 5 \text{ mA}$

### RF Electrical Parameters at $T_A=25^{\circ}\!\mathrm{C}$

Part Number HSMS-	Typical Conversion Loss $L_{C}$ (dB)	Typical IF Impedance $\mathbf{Z}_{ ext{IF}}$ $(\Omega)$	Typical SWR	Typical Tangential Sensitivity T <sub>SS</sub> (dBm)
8002	5.5	150	1.2:1	-46
Test	f = 10 GHz BW = 2 MHz			
Conditions	$f = 16 \text{GHz}$ $DC  load  resistance = 0  \Omega$	$I_{BIAS} = 20 \mu\text{A}$		

<sup>1.</sup> Standard batch match size, 100 units. 2. To obtain  $R_{\rm S}$ , subtract  $26/5=5.2\,\Omega$ .

# DC Electrical Specifications at $T_A = 25\,^{\circ}\mathrm{C}$ Schottky Barrier Chips for Microwave and RF Detectors

Part Number HSMS-	Nearest Equivalent Packaged Part No. HSMS-	$\begin{array}{c} \textbf{Maximum} \\ \textbf{Forward Voltage} \\ \textbf{V}_{\textbf{F}} \ (\textbf{mV}) \end{array}$	Minimum Breakdown Voltage V <sub>BR</sub> (V)	Typical Capacitance C <sub>T</sub> (pF)
0005	2850	250	_	0.20
0006	2860	350	4.0	0.17
Test Conditions		$I_F = 1 \text{ mA}$	$I_R = 10 \mu\text{A}$	$V_R = 0.5 V,$ f = 1 MHz

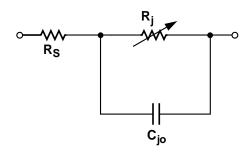
### Typical RF Electrical Parameters at $T_{\rm A}$ = 25 $^{\circ}{\rm C}$

Part Number		Voltage Sensitivity $\gamma$ (mV/ $\mu$ W)			Video Resistance
HSMS-	DC Bias	915 MHz	$\mathbf{R}_{\mathbf{V}}$ (K $\Omega$ )		
0005	zero	40	30	22	8.0
0006	5 μΑ	40 32 25			5.5
Test Conditions		$P_{in} = -40$			

### **SPICE Parameters**

Parameter	Units	HSMS-8002	HSMS-0005	HSMS-0006
B <sub>V</sub>	V	7.0	3.8	6.0
$C_{J0}$	pF	0.16	0.16	0.17
$\mathrm{E}_{\mathrm{G}}$	eV	0.69	0.69	0.69
$I_{\mathrm{BV}}$	A	10E-5	10E-5	10E-5
$I_{\mathrm{S}}$	A	4.6 x 10E-8	3x10E-6	3x10E-8
N		1.08	1.15	1.10
$R_{S}$	Ω	5.0	20	7.0
$P_{\mathrm{B}}$	V	0.65	0.65	0.65
$P_{\mathrm{T}}$		2	2	2
M		0.5	0.5	0.5

### **Equivalent Circuit Model**



$$R_j \approx \frac{.026}{I_s + I_b}$$

 $I_b$  = bias current in A

### Assembly and Handling Procedures for Schottky Chips

#### 1. Storage

Devices should be stored in a dry nitrogen purged desiccator or equivalent.

### 2. Cleaning

If required, surface contamination may be removed with electronic grade solvents such as freon (T.F. or T.M.C.), acetone, deionized water, and methanol used singularly or in combinations. Typical cleaning times per solvent are one to three minutes. DI water and methanol should be used (in that order) in the final cleansing. Final

drying can be accomplished by placing the cleaned dice on clean filter paper and drying with an infrared lamp for 5–10 minutes. Acids such as hydrofluoric (HF), nitric (HNO<sub>3</sub>) and hydrochloric (HCl) must not be used.

The effects of cleaning methods/ solutions should be verified on small samples prior to submitting the entire lot.

Following cleaning, dice should either be used in assembly (typically within a few hours) or stored in clean containers in an inert atmosphere or a vacuum chamber.

### 3. Die Attach

#### a. Eutectic

Eutectic die attach can be accomplished by "scrubbing" the die with a preform on the header. (Note—times and temperature utilized vary depending on the type of preform.) For example, 310°C is suitable for a Au/Sn preform.

#### b. Epoxy

For epoxy die-attach, conducive silver-filler epoxies are recommended. This method can be used for all Hewlett-Packard Schottky chips.

#### 4. Wire Bonding

Thermocompression wire bonding is recommended. Suggested wire is pure gold, 0.7 to 1.5 mil diameter.